

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To Be Assigned

Examiner: To Be Assigned

In re PATENT APPLICATION of:

Applicant(s) : Hiroyuki FUJIWARA et al.

Appln. No. : To Be Assigned

Filed : August 1, 2003

For : SEMICONDUCTOR ARRAY DEVICE  
WITH SINGLE INTERCONNECTION  
LAYER

Atty. Dkt. : MAE 290

**INFORMATION  
DISCLOSURE  
STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(1).

Attached is a copy of a Japanese publication. Any relevance of the Japanese publication can be gleaned from the attached English-language Abstract. The document is listed on the attached Form PTO-1449.

Since this Information Disclosure Statement is being filed with the application, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to the document submitted. Consideration of the submitted document is respectfully requested.

Respectfully submitted,



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August 1, 2003  
Date

RHB:tl

FEE ENCLOSED: \$  
Please charge any further  
fee to our Deposit Account  
No. 18-0002

**PROPOSED INFORMATION DISCLOSURE STATEMENT**

**PARTICULARS**

- (1) Japanese Patent Kokai Publication No. 2001-077431  
Date of Publication: March 23, 2001  
Inventor(s): Hiroshi HAMANO, et al.  
Applicant: Oki Electric Industry Co., Ltd.  
Title of the Invention: Light-Emitting Element Array

**EXPLANATION**

- (1) An English abstract is attached.

<b>FORM PTO-1449</b>  <b>INFORMATION DISCLOSURE STATEMENT</b>				Atty Docket		Application No.	
				MAE 290		To Be Assigned	
				Applicant			
				Hiroyuki FUJIWARA et al.			
				Filing Date		Group Unit	
				August 1, 2003		To Be Assigned	
<b>U.S. PATENT DOCUMENTS</b>							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
<b>FOREIGN PATENT DOCUMENTS</b>							
		Document Number	Date	Country	Class	Sub-Class	Translation
	AH	2001-77431	03/23/01	Japan			Abstract
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
<b>OTHER (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AO						
	AP						
	AQ						
	AR						
Examiner					Date Considered		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							